

Notice of References Cited	Application/Control No. 10/608,678	Applicant(s)/Patent Under Reexamination YOO ET AL.	
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*	B	US-6,346,181	02-2002	Lee et al.	205/89
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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